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XN0NE92

Silicon P-channel MOSFET (FET) Silicon epitaxial planar type (SBD)

For DC-DC converter

■ Features

- Two elements incorporated into one package
- Reduction of the mounting area and assembly cost by one half
- High-speed switching, low on resistance

■ Absolute Maximum Ratings $T_a = 25$ °C

	Parameter	Symbol	Rating	Unit	3: Gate	
FET	Drain-source surrender	V _{DSS}	-12	V	■ Marki	na Su
	voltage				■ IVIAIKI	ily Sy
	Gate-source surrender	V _{GSS}	±15	V		
	voltage				■ Internal	nal Cor
	Drain current	I_{D}	-1.2	A		
	Peak drain current	I _{DP}	-3	A		(A)
	Total power dissipation.*	\mathbf{P}_{T}	600	mW		
	Channel temperature	T_{ch}	125	°C		xep
	Storage temperature	T_{stg}	-55 to +125	°C		⊘ *
SBD	Reverse voltage	V_R	20	V		
	Repetitive peak reverse voltage	V_{RRM}	25	V	100 is	
	Forward current (Average)	I _{F(AV)}	700	mA	Co off	(K)
	Non-repetitive peak	I _{FSM}	2	A	~\so	
	forward surge current				.16,	
Note) *: N	deasuring on ceramic substrat	e at 15 mm	$1 \times 15 \text{ mm} \times 0$).6 mm	5. .,	
	1 > + C		. 👌	N, C.		
■ Elect	rica Characteristics 1	$\Gamma_{\rm a} = 25^{\circ}$	C ± 3°C	de		
• FET			ix XV	NS C		
	Channel temperature Storage temperature Reverse voltage Repetitive peak reverse voltage Forward current (Average) Non-repetitive peak forward surge current Abasuring on ceramic substrate rical Characteristics Parameter surce surrender voltage surce cutoff current	Symbo	(b) VI	Condition	s	Min
Drain-so	ource surrender voltage	W ss	√(2 1 m.	$A, V_{GS} = 0$		-12
Drain-so	ource cutoff current	DSSX	$\mathbf{\hat{V}}_{\mathrm{DS}} = -10$	$V, V_{GS} = 0$		

Note) *: N

Package

Cod

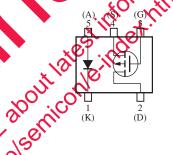
ource 2: Drain

Exclusive use for XN0NE92)

Gate

Marking

nternal Connection ?



Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Drain-source surrender voltage	W ss	$V_{\rm GS} = 0$	-12			V
Drain-source cutoff current	O P _{DSS} X	$V_{DS} = -10 \text{ V}, V_{GS} = 0$			-1	V
Gate-source cutoff current	1963	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0$			±10	V
Gate threshold voltage	V _{th}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	- 0.4		-1.3	V
Forward transfer admittance *	Yfs	$V_{DS} = -10 \text{ V}, I_{D} = -800 \text{ mA}$	0.8	1.1		S
Drain-source ON resistance *	R _{DS(on)}	$V_{GS} = -4 \text{ V}, I_D = -800 \text{ mA}$		350	450	mΩ
Turn-on time	t _{on}	$V_{DD} = -10 \text{ V}, R_L = 12.5 \Omega,$		15		ns
Storage time	t _{stg}	$I_D = -800 \text{ mA}, V_{GS} = 0 \text{ V to } -4 \text{ V}$		10		ns
Turn-off time	t _{off}			10		ns

- Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.
 - 2. Observe precautions for handling. Electrostatic sensitive devices.
 - 3. *: Pulse measurement

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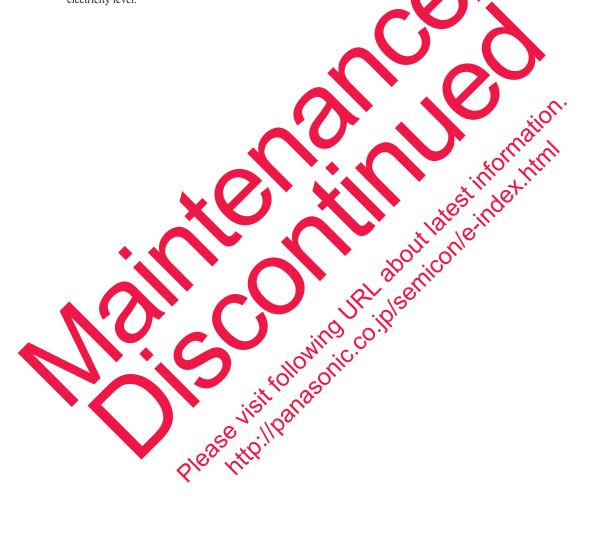
■ Electrical Characteristics (continued) $T_a = 25$ °C ± 3 °C

• SBD

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward voltage	V _F	$I_F = 700 \text{ mA}$			0.45	V
Reverse current	I_R	$V_R = 20 \text{ V}$			200	μΑ
Terminal capacitance	Ct	$V_R = 0$, $f = 1$ MHz		100		pF
Reverse recovery time	t _{rr}	$I_F = I_R = 100 \text{ mA}$		7		ns
		$I_{rr} = 10 \text{ mA}, R_L = 100 \Omega$				

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 Measuring methods for diodes.

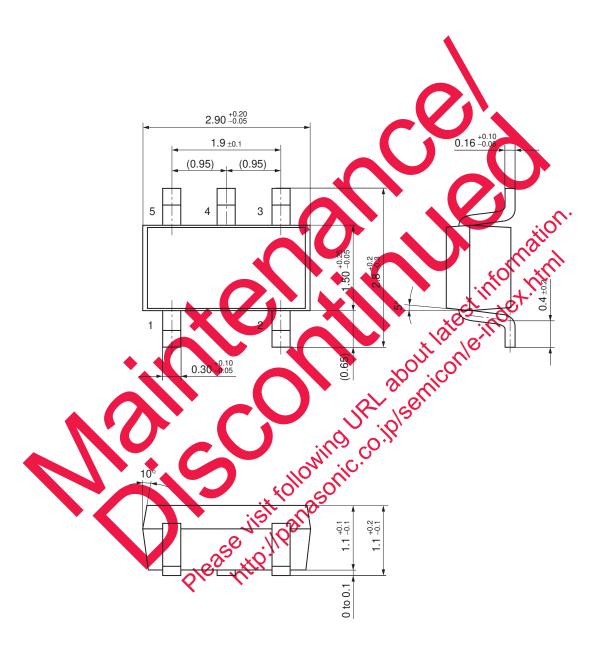
2. Schottky barrier diode is frail with static electricity, and it should be kept in safety from shock of static electricity and static electricity level.



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Unit: mm

Mini5-G1 (Exclusive use for XN0NE92)



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